

#### 4. Absolute Maximum Ratings (Note) ( $T_a = 25^\circ\text{C}$ unless otherwise specified)

| Characteristics                                | Symbol           | Rating     | Unit             |
|--|------------------|------------|------------------|
| Drain-source voltage                           | $V_{\text{DSS}}$ | 650        | V                |
| Gate-source voltage                            | $V_{\text{GSS}}$ | $\pm 30$   |                  |
| Drain current (DC) (Note 1)                    | $I_{\text{D}}$   | 11.1       | A                |
| Drain current (pulsed) (Note 1)                | $I_{\text{DP}}$  | 44.4       |                  |
| Power dissipation ( $T_c = 25^\circ\text{C}$ ) | $P_{\text{D}}$   | 100        | W                |
| Single-pulse avalanche energy (Note 2)         | $E_{\text{AS}}$  | 138        | mJ               |
| Avalanche current                              | $I_{\text{AR}}$  | 2.8        | A                |
| Reverse drain current (DC) (Note 1)            | $I_{\text{DR}}$  | 11.1       |                  |
| Reverse drain current (pulsed) (Note 1)        | $I_{\text{DRP}}$ | 44.4       |                  |
| Channel temperature                            | $T_{\text{ch}}$  | 150        | $^\circ\text{C}$ |
| Storage temperature                            | $T_{\text{stg}}$ | -55 to 150 |                  |

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

#### 5. Thermal Characteristics

| Characteristics                    | Symbol                | Max  | Unit               |
|------------------------------------|-----------------------|------|--------------------|
| Channel-to-case thermal resistance | $R_{\text{th(ch-c)}}$ | 1.25 | $^\circ\text{C/W}$ |

Note 1: Ensure that the channel temperature does not exceed  $150^\circ\text{C}$ .

Note 2:  $V_{\text{DD}} = 90\text{ V}$ ,  $T_{\text{ch}} = 25^\circ\text{C}$  (initial),  $L = 31.2\text{ mH}$ ,  $R_{\text{G}} = 25\ \Omega$ ,  $I_{\text{AR}} = 2.8\text{ A}$

Note: This transistor is sensitive to electrostatic discharge and should be handled with care.

## 6. Electrical Characteristics

### 6.1. Static Characteristics ( $T_a = 25^\circ\text{C}$ unless otherwise specified)

| Characteristics                | Symbol        | Test Condition                                     | Min | Typ. | Max     | Unit          |
|--------------------------------|---------------|--|-----|------|---------|---------------|
| Gate leakage current           | $I_{GSS}$     | $V_{GS} = \pm 30\text{ V}$ , $V_{DS} = 0\text{ V}$ | —   | —    | $\pm 1$ | $\mu\text{A}$ |
| Drain cut-off current          | $I_{DSS}$     | $V_{DS} = 650\text{ V}$ , $V_{GS} = 0\text{ V}$    | —   | —    | 10      |               |
| Drain-source breakdown voltage | $V_{(BR)DSS}$ | $I_D = 10\text{ mA}$ , $V_{GS} = 0\text{ V}$       | 650 | —    | —       | V             |
| Gate threshold voltage         | $V_{th}$      | $V_{DS} = 10\text{ V}$ , $I_D = 0.45\text{ mA}$    | 2.5 | —    | 3.5     |               |
| Drain-source on-resistance     | $R_{DS(ON)}$  | $V_{GS} = 10\text{ V}$ , $I_D = 5.5\text{ A}$      | —   | 0.35 | 0.44    | $\Omega$      |

### 6.2. Dynamic Characteristics ( $T_a = 25^\circ\text{C}$ unless otherwise specified)

| Characteristics                | Symbol      | Test Condition   | Min | Typ. | Max | Unit     |
|--------------------------------|-------------|--|-----|------|-----|----------|
| Input capacitance              | $C_{iss}$   | $V_{DS} = 300\text{ V}$ , $V_{GS} = 0\text{ V}$ , $f = 1\text{ MHz}$ | —   | 890  | —   | pF       |
| Reverse transfer capacitance   | $C_{rss}$   |  | —   | 2.8  | —   |          |
| Output capacitance             | $C_{oss}$   |  | —   | 23   | —   |          |
| Effective output capacitance   | $C_{o(er)}$ | $V_{DS} = 0\text{ to }400\text{ V}$ , $V_{GS} = 0\text{ V}$          | —   | 38   | —   |          |
| Gate resistance                | $r_g$       | $V_{DS} = \text{OPEN}$ , $f = 1\text{ MHz}$                          | —   | 6.5  | —   | $\Omega$ |
| Switching time (rise time)     | $t_r$       | See Figure 6.2.1   | —   | 23   | —   | ns       |
| Switching time (turn-on time)  | $t_{on}$    |  | —   | 45   | —   |          |
| Switching time (fall time)     | $t_f$       |  | —   | 5.5  | —   |          |
| Switching time (turn-off time) | $t_{off}$   |  | —   | 85   | —   |          |
| MOSFET dv/dt ruggedness        | dv/dt       | $V_{DD} = 0\text{ to }400\text{ V}$ , $I_D = 5.5\text{ A}$           | 50  | —    | —   | V/ns     |

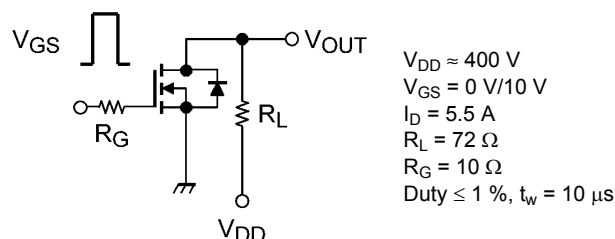


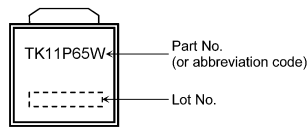
Fig. 6.2.1 Switching Time Test Circuit

### 6.3. Gate Charge Characteristics ( $T_a = 25^\circ\text{C}$ unless otherwise specified)

| Characteristics                                 | Symbol    | Test Condition   | Min | Typ. | Max | Unit |
|---|-----------|--|-----|------|-----|------|
| Total gate charge (gate-source plus gate-drain) | $Q_g$     | $V_{DD} \approx 400\text{ V}$ , $V_{GS} = 10\text{ V}$ , $I_D = 11.1\text{ A}$ | —   | 25   | —   | nC   |
| Gate-source charge 1                            | $Q_{gs1}$ |  | —   | 6    | —   |      |
| Gate-drain charge                               | $Q_{gd}$  |  | —   | 11   | —   |      |

### 6.4. Source-Drain Characteristics ( $T_a = 25^\circ\text{C}$ unless otherwise specified)

| Characteristics               | Symbol    | Test Condition  | Min | Typ. | Max  | Unit          |
|-------------------------------|-----------|---|-----|------|------|---------------|
| Diode forward voltage         | $V_{DSF}$ | $I_{DR} = 11.1\text{ A}$ , $V_{GS} = 0\text{ V}$  | —   | —    | -1.7 | V             |
| Reverse recovery time         | $t_{rr}$  | $I_{DR} = 5.5\text{ A}$ , $V_{GS} = 0\text{ V}$<br>$-dI_{DR}/dt = 100\text{ A}/\mu\text{s}$ | —   | 230  | —    | ns            |
| Reverse recovery charge       | $Q_{rr}$  |   | —   | 2.3  | —    | $\mu\text{C}$ |
| Peak reverse recovery current | $I_{rr}$  |   | —   | 20   | —    | A             |
| Diode dv/dt ruggedness        | dv/dt     | $I_{DR} = 5.5\text{ A}$ , $V_{GS} = 0\text{ V}$ , $V_{DD} = 400\text{ V}$                   | 15  | —    | —    | V/ns          |

**7. Marking****Fig. 7.1 Marking**

## 8. Characteristics Curves (Note)

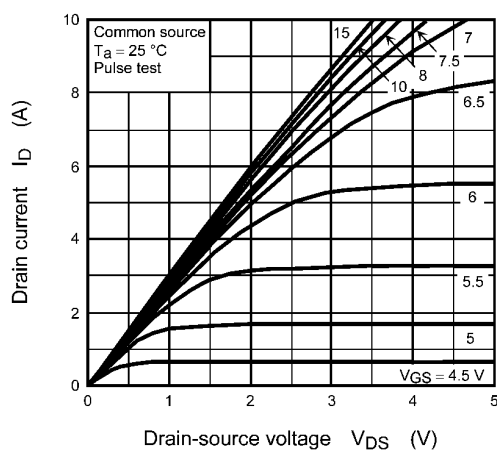


Fig. 8.1  $I_D - V_{DS}$

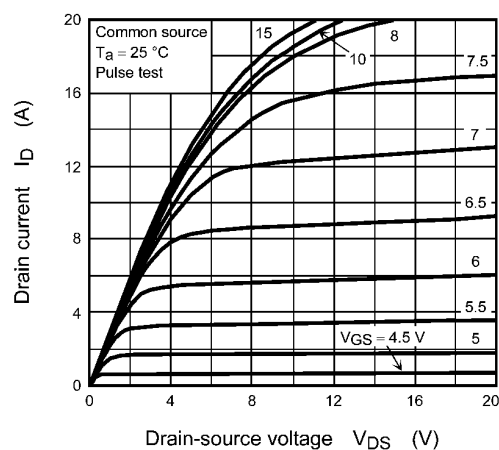


Fig. 8.2  $I_D - V_{DS}$

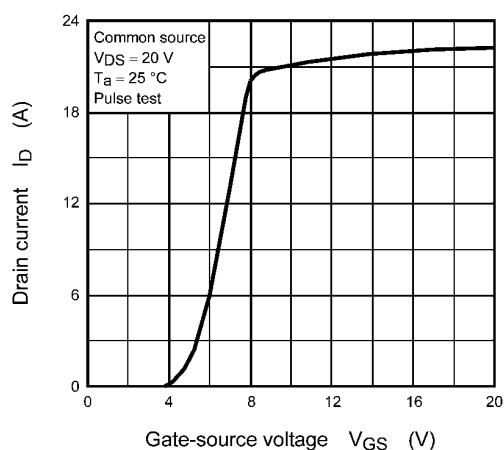


Fig. 8.3  $I_D - V_{GS}$

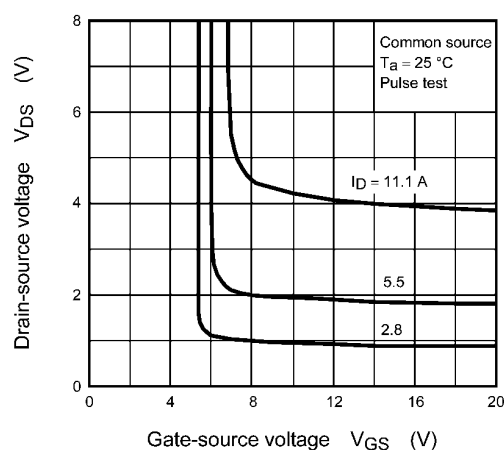


Fig. 8.4  $V_{DS} - V_{GS}$

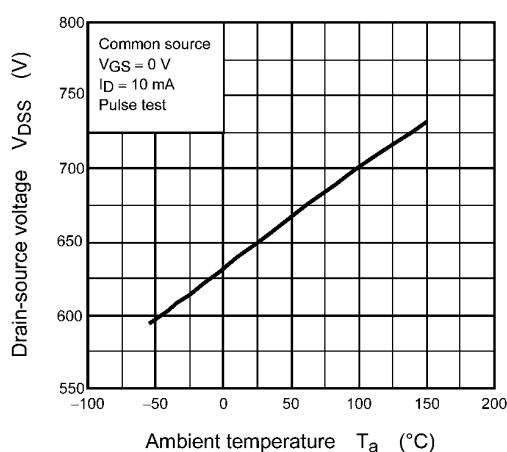


Fig. 8.5  $V_{DS} - T_a$

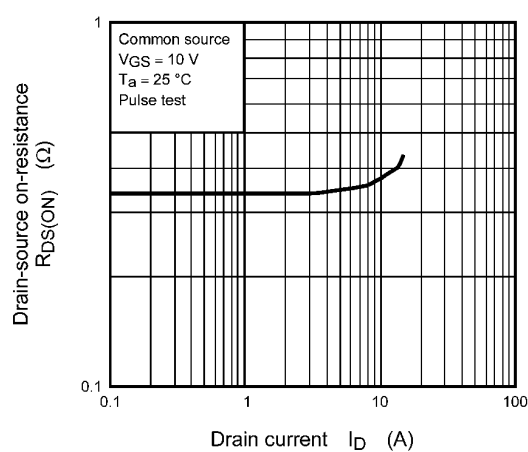


Fig. 8.6  $R_{DS(ON)} - I_D$

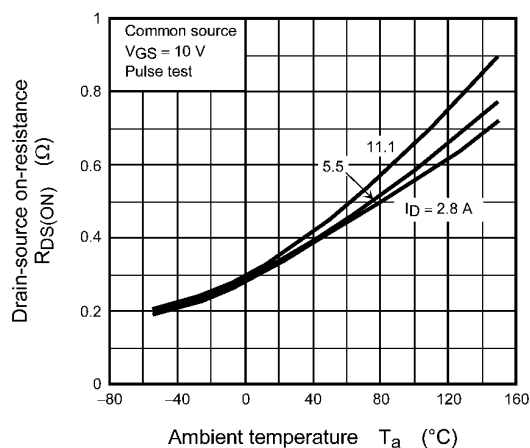
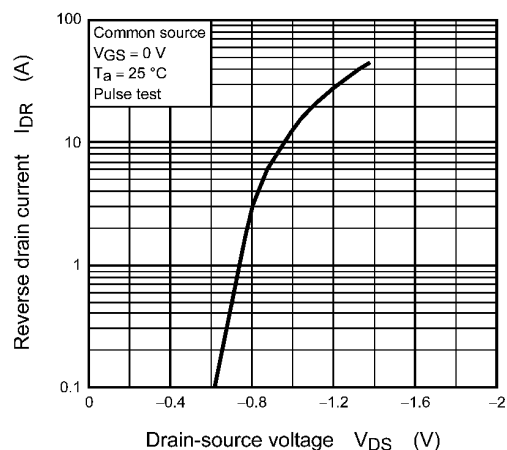
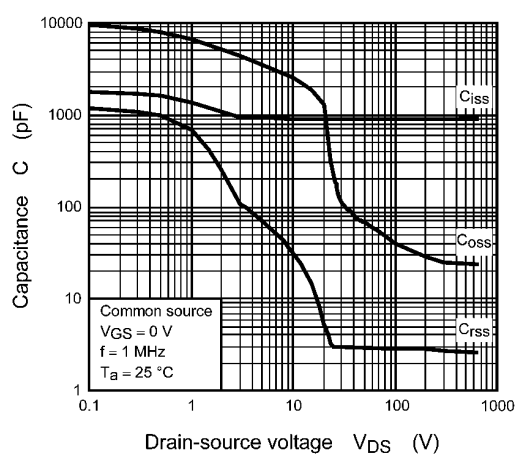
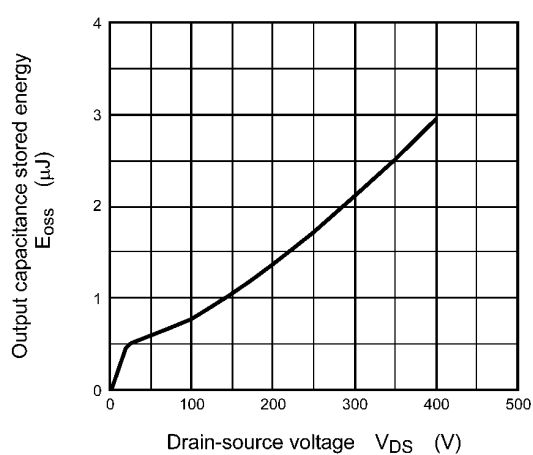
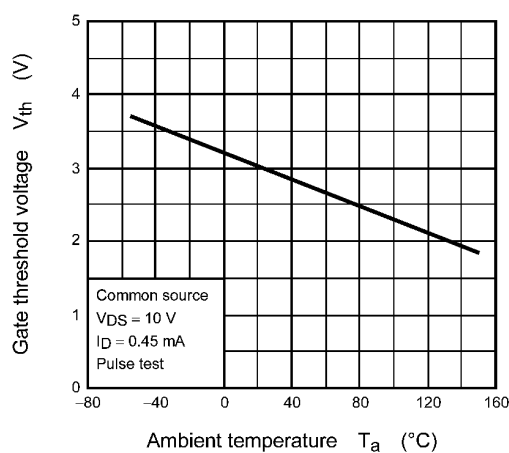
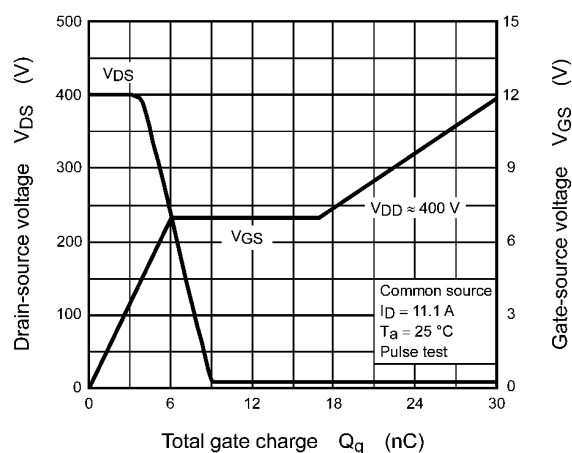
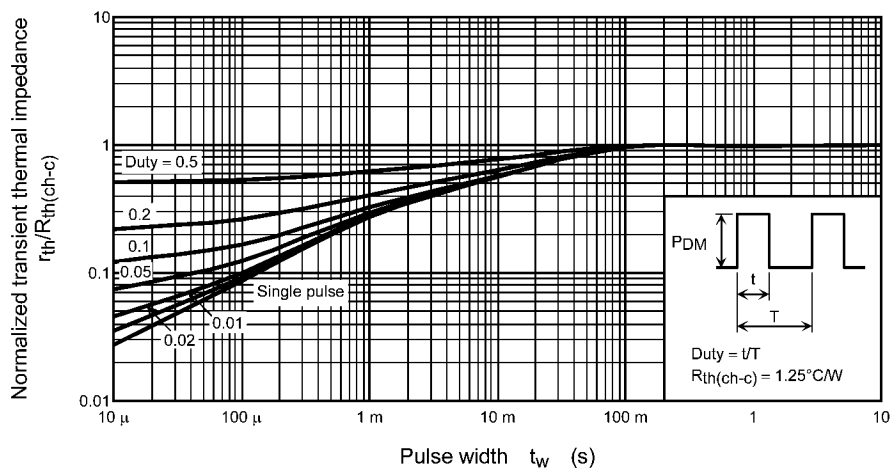
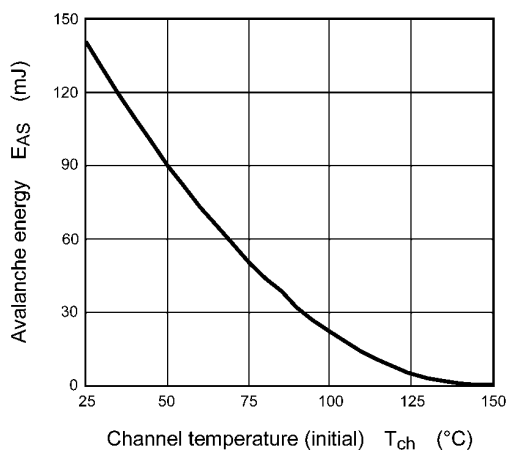
Fig. 8.7  $R_{DS(ON)} - T_a$ Fig. 8.8  $I_{DR} - V_{DS}$ Fig. 8.9  $C - V_{DS}$ Fig. 8.10  $E_{OSS} - V_{DS}$ Fig. 8.11  $V_{th} - T_a$ 

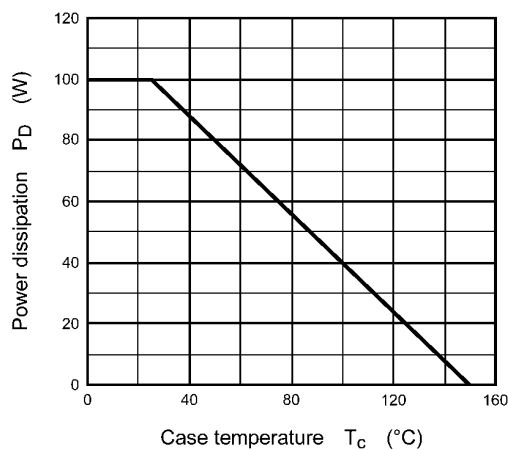
Fig. 8.12 Dynamic Input/Output Characteristics



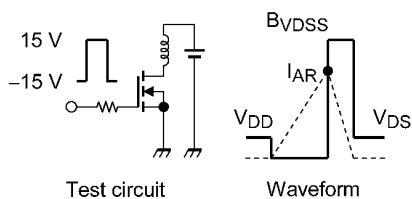
**Fig. 8.13  $r_{th} - t_w$**   
(Guaranteed Maximum)



**Fig. 8.14  $E_{AS} - T_{ch}$**   
(Guaranteed Maximum)

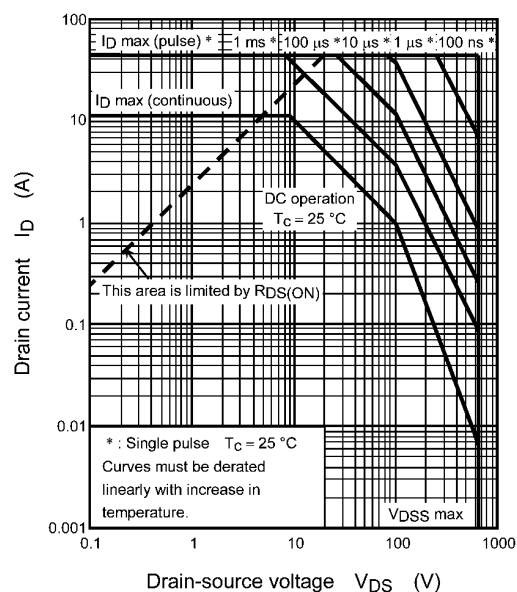


**Fig. 8.15  $P_D - T_c$**   
(Guaranteed Maximum)



$$R_G = 25 \, \Omega, V_{DD} = 90 \, \text{V} \quad E_{AS} = \frac{1}{2} \cdot L \cdot I_{AR}^2 \cdot \left( \frac{B_{VDSS}}{B_{VDSS} - V_{DD}} \right)$$

**Fig. 8.16 Test Circuit/Waveform**

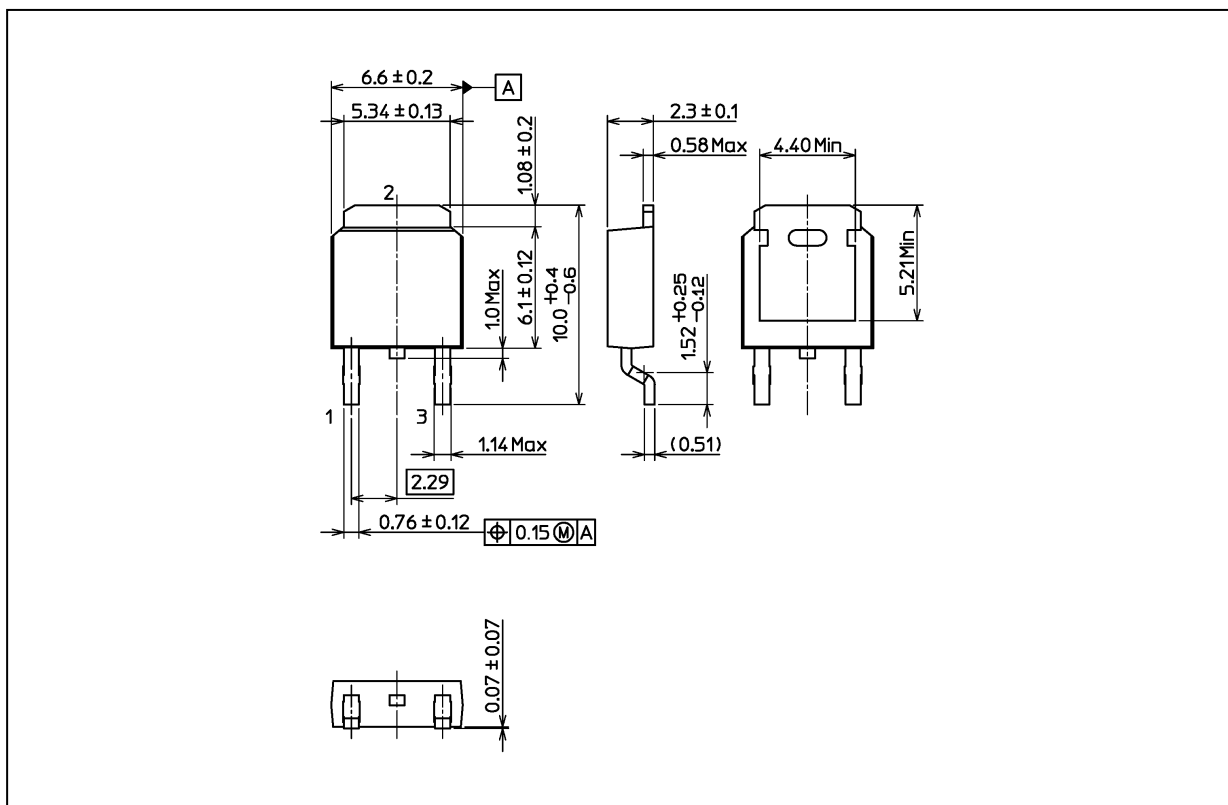


**Fig. 8.17 Safe Operating Area  
(Guaranteed Maximum)**

Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

## Package Dimensions

Unit: mm



Weight: 0.36 g (typ.)

| Package Name(s) |
|-----------------|
| TOSHIBA: 2-7K1S |
| Nickname: DPAK  |



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